Attendance:

Mr. Bryan Kantack Agilent Technologies, Inc.

Mr. Jesse Jaramillo Amphenol
Mr. Greg McSorley Amphenol
Mr. Mickey Felton EMC
Mr. Ramez Rizk Emulex

Mr. Barry Olawsky
Mr. Harvey Newman
Hewlett Packard Co.
Infineon Technologies

Mr. Michael Jenkins LSI Corp. Mr. Gabriel Romero LSI Corp.

Mr. Jacky Chow Marvell Semiconductor, Inc.

Mr. Galen Fromm
Molex Inc.
Mr. Rick Hernandez
Mr. Guillaume Fortin
Mr. Yuming Tao
Mr. Joseph Chen
Molex Inc.
PMC-Sierra
PMC-Sierra
PMC-Sierra
Samsung

Mr. Alvin Cox
Mr. Allen Kramer
Mr. Bruce Johnson
Mr. Himanshu Desia
Mr. Benoit Mercier

Seagate Technology
Seagate Technology
Seagate Technology
Seagate Technology
STMicroelectonics

Mr. Bent Hessen-Schmidt Synthesys Research, Inc.

Mr. Mike Fogg TycoElectronics

Mr. Mahbubul Bari Vitesse Semiconductor

Mr. Larry McMillan WDC Mr. Ramya Dissanayake WDC

25 in attendance

Agenda:

1. SAS-2 Calibration of Jitter Measurement Devices [Cox] http://www.t10.org/ftp/t10/document.07/07-443r1.pdf Expecting something next week.

2. Transmitter common mode measurements to validate the currently proposed chart. [Seagate to present; Intel, LSI looking at providing data] Updated data posted at: http://www.t10.org/ftp/t10/document.07/07-445r1.pdf

Measurements made through SAS mated pair will be included next week along with scope measurements for comparison. Discussion indicated that including the SAS connector could influence the results to be either better or worse. Data is needed to decide on the limit value, whether to include the SAS connector, shape of the graph, test methodology, and the required test data pattern.

- 3. Description of SSC profile allowed discontinuities. [Hernandez] No update.
- 4. Should the cable specification be done by common mode requirements or fall under channel simulation? [Amphenol]

Amphenol believes that both parameters will be asked for by some. They are still wrestling with what to propose. Hope to have something out for review next week.

- 5. Define the delivered signal characteristics for physical receiver testing. Include 0.1UI sinusoidal jitter to do the equivalent of receiver tolerance testing. [Bari, Jenkins, Newman, Witt] Additional data has been collected but it was not yet in a presentable format.
- 6. Refine/provide status on simulation technology. [Jenkins, Newman]

An optimized version of code now available on the StatEye web site. The revised version runs much quicker than previous ones.

http://www.t10.org/ftp/t10/document.07/07-463r0.pdf

Concern brought up that backplane simulations have not been run/confirmed, however, the original StatEye was primarily developed for backplane analysis. Expectations for November T10 meeting:

- Present final silicon cross correlation.
- Propose receiver and transmitter electrical characteristics for standard based on 6Gbps silicon measurement.
- Present final proposal for transmitter, channel and receiver compliance methodology.
- Report on engagement of Edotronik for development of GUI and API to measurement equipment.

New item:

SAS-2 Mini SAS 8i connectors and cable assemblies [Elliott] http://www.t10.org/ftp/t10/document.07/07-449r0.pdf

Barry indicated that the sideband location needs to be reviewed by those who manufacture cables or intend to use this new internal version. Please review. This item is planned to be included in SAS2.

Next conference call: November 1, 2007

Toll Free Dial in Number: (877)810-9442

International Access/Caller Paid Dial In Number: (636)651-3190

PARTICIPANT CODE: 3243413

Webex information:

https://seagate.webex.com/seagate

Topic: SAS-2 PHY WG

Date: Thursday

Time: 10:00 am, Central Daylight Time (GMT -05:00, Chicago)

Meeting number: 826 515 680 Meeting password: 6gbpsSAS